

**Notice of References Cited**

Application/Control No.

10/632,013

Applicant(s)/Patent Under  
Reexamination  
BASAK ET AL.

Examiner

Asfand M. Sheikh

Art Unit

3627

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,254,552	08-2007	Bezos et al.	705/26
*	B	US-7,249,067	07-2007	Doerksen et al.	705/27
*	C	US-7,228,283	06-2007	Hornstein, David	705/10
*	D	US-6,978,273	12-2005	Bonneau et al.	707/102
*	E	US-6,963,850	11-2005	Bezos et al.	705/26
*	F	US-6,907,566	06-2005	McElfresh et al.	715/210
*	G	US-6,286,005	09-2001	Cannon, Mark E.	707/100
*	H	US-6,064,980	05-2000	Jacobi et al.	705/26
*	I	US-2003/0216930	11-2003	Dunham et al.	705/1
*	J	US-2003/0055729	03-2003	Bezos et al.	705/14
*	K	US-2003/0009448	01-2003	Covington et al.	707/3
*	L	US-2002/0143603	10-2002	Moore, Bruce Wayne	705/10
*	M	US-2002/0082953	06-2002	Batham et al.	705/27

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	W					
	X					

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.